

# PRODUCT RELIABILITY REPORT FOR

### **MAX34408**

## **Maxim Integrated**

14460 Maxim Dr. Dallas, TX 75244

Approved by:

Sokhom Chum SMTS, Reliability Engineering

#### Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim Integrated products:

#### MAX34408

In addition, Maxim Integrated's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at http://www.maximintegrated.com/ga/reliability/monitor.

#### **Device Description:**

A description of this device can be found in the product data sheet. You can find the product data sheet at http://www.maximintegrated.com/search/parts.mvp.

#### **Reliability Derating:**

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

AfT = exp((Ea/k)\*(1/Tu - 1/Ts)) = tu/ts

AfT = Acceleration factor due to Temperature

tu = Time at use temperature (e.g. 55 °C)

ts = Time at stress temperature (e.g. 125 °C)

k = Boltzmann's Constant (8.617 x 10-5 eV/ °K)

Tu = Temperature at Use ( °K)

Ts = Temperature at Stress ( °K)

Ea = Activation Energy (e.g. 0.7 ev)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

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AfV = exp(B*(Vs - Vu))

AfV = Acceleration factor due to Voltage

Vs = Stress Voltage (e.g. 7.0 volts)

Vu = Maximum Operating Voltage (e.g. 5.5 volts)

B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)
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The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

Fr = X/(ts \* AfV \* AfT \* N \* 2) X = Chi-Sq statistical upper limit N = Life test sample size Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

MTTF = 1/Fr

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE: MTTF (YRS): 3610 FITS: 31.6

DEVICE HOURS: 28974094 FAILS: 0

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% Ea: 0.7 B: 0 Tu: 25 ℃ Vu: 3.6 Volts

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

#### **Device Information:**

Process: Maxim SA Fab S45

Passivation: SiN/SiO2
Die Size: 79 x 77
Number of Transistors: 22123

Interconnect: Aluminum / 0.5% Copper

Gate Oxide Thickness: 140Å

ESD HBM									
DESCRIPTION	DATE	CODE/PRODUCT	LOT	CONDITION	REAL	OPOIN	QTY	FAILS	FA#
ESD SENSITIVITY	1325	MAX34411	ZS386213CB	JESD22-A114 HBM 500 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1325	MAX34411	ZS386213CB	JESD22-A114 HBM 1000 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1325	MAX34411	ZS386213CB	JESD22-A114 HBM 1500 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1325	MAX34411	ZS386213CB	JESD22-A114 HBM 2000 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1325	MAX34411	ZS386213CB	JESD22-A114 HBM 2500 VOLTS	1	PUL'S	5	0	
					Total	•		0	
LATCH-UP				_					
DESCRIPTION	DATE	CODE/PRODUCT	/LOT	CONDITION	REAL	OPOIN	QTY	FAILS	FA#

LATCH-OF							
DESCRIPTION	DATE CODE/PRODUCT	/LOT CONE	DITION	READPOIN	QTY F	AILS	FA#
LATCH-UP I	1325 <b>MAX34411</b>	ZS386213CB JESD 100m	*		6	0	
LATCH-UP V	1325 <b>MAX34411</b>	ZS386213CB JESD TEST	,		6	0	
				Total:		0	
				Total:		0	

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DESCRIPTION DATE CODE/PRODUCT/LOT CONDITION READPOIN QTY FAILS FA#

				Total	:		0
HIGH TEMP OP LIFE	1325	MAX34411	ZS386213CB 125C, 3.6 VOLTS	192	HRS	80	0
HIGH TEMP OP LIFE	1231	MAX31865	ZJ381729AB-125C, 3.7V (PSA)	192	HRS	80	0

FAILURE RATE: MTTF (YRS): 3610 FITS: 31.6

DEVICE HOURS: 28974094 FAILS: 0

MAX34408 is built with the identical die of MAX34411.